



Power MOSFETS

DATASHEET

LM20B50CGF6A

N-Channel AND P-Channel
Enhancement Mode MOSFET

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Quality Management Systems
ISO 9001:2015 Certificate

LM20B50CGF6A

N-Channel AND P-Channel Enhancement Mode MOSFET

Pin Description

SOT-363 (TOP view)	Symbol	Symbol	N-Channel	P-Channel	Unit	
			V _{DSS}	20	-20	V
			R _{DSON} (max)	300	600	mΩ
			I _D	0.72	-0.53	A

Feature

- Reliable and Rugged
- ROHS Compliant & Halogen-Free
- ESD Protection

Ordering Information

Orderable Part Number	Package Type	Form	Shipping	Marking
LM20B50CGF6A	SOT-363	Reel	3000 / Reel	3□□□

Note : □□□= Lot Code

Absolute Maximum Ratings (T_J=25°C Unless Otherwise Noted)

Symbol	Parameter	N-Channel	P- Channel	Unit	
V _{DSS}	Drain-Source Voltage	20	-20	V	
V _{GSS}	Gate-Source Voltage	±12	±12		
T _J	Maximum Junction Temperature	150	150	°C	
T _{STG}	Storage Temperature Range	-55 to 150	-55 to 150	°C	
I _{DM} ^①	Pulse Drain Current Tested	T _A =25°C	0.9	-0.9	A
I _D	Continuous Drain Current	T _A =25°C	0.72	-0.53	A
		T _A =70°C	0.57	-0.42	
P _D	Maximum Power Dissipation	T _A =25°C	0.25	W	
		T _A =70°C	0.16		

Thermal Characteristics

Symbol	Parameter	Rating	Unit
R _{θJA} ^③	Thermal Resistance-Junction to Ambient	Steady State	500 °C/W

Note ① : Max. current is limited by bonding wire.

Note ② : UIS tested and pulse width are limited by maximum junction temperature 150°C

Note ③ : Surface Mounted on 1in² FR-4 board with 1oz.

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N-Channel Electrical Characteristics ($T_J=25^\circ\text{C}$ Unless Otherwise Noted)

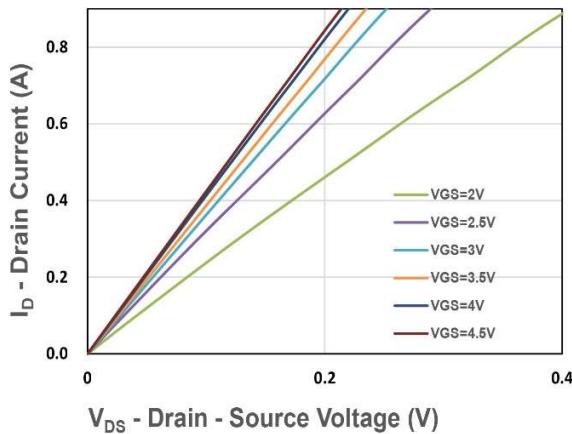
Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
Static Electrical Characteristics						
$\mathbf{BV_{DSS}}$	Drain-Source Breakdown Voltage	$V_{GS}=0\text{V}, I_{DS}=250\mu\text{A}$	20	-	-	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=16\text{V}, V_{GS}=0\text{V}$	-	-	1	μA
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_{DS}=250\mu\text{A}$	0.5	0.75	1	V
I_{GSS}	Gate Leakage Current	$V_{GS}=\pm 12\text{V}, V_{DS}=0\text{V}$	-	-	± 10	μA
$R_{DS(\text{ON})}^{\text{(4)}}$	Drain-Source On-state Resistance	$V_{GS}=4.5\text{V}, I_{DS}=0.6\text{A}$	-	245	300	$\text{m}\Omega$
		$V_{GS}=2.5\text{V}, I_{DS}=0.4\text{A}$	-	310	400	
		$V_{GS}=1.8\text{V}, I_{DS}=0.35\text{A}$	-	420	580	
g_{fs}	Forward Transconductance	$V_{DS}=3\text{V}, I_{DS}=0.3\text{A}$	-	0.9	-	S
Dynamic Characteristics ⁽⁵⁾						
C_{iss}	Input Capacitance	$V_{GS}=0\text{V}, V_{DS}=10\text{V}, \text{Freq.}=1\text{MHz}$	-	40	-	pF
C_{oss}	Output Capacitance		-	17	-	
C_{rss}	Reverse Transfer Capacitance		-	9.9	-	
$t_{d(\text{ON})}$	Turn-on Delay Time	$V_{GS}=4.5\text{V}, V_{DS}=10\text{V}, I_D=2\text{A}, R_{GEN}=6\Omega$	-	1.2	-	nS
t_r	Turn-on Rise Time		-	24.5	-	
$t_{d(\text{OFF})}$	Turn-off Delay Time		-	13.6	-	
t_f	Turn-off Fall Time		-	14.6	-	
Q_g	Total Gate Charge	$V_{GS}=2.5\text{V}, V_{DS}=10\text{V}, I_D=1\text{A}$	-	0.54	-	nC
Q_g	Total Gate Charge	$V_{GS}=4.5\text{V}, V_{DS}=10\text{V}, I_D=1\text{A}$	-	1	-	
Q_{gs}	Gate-Source Charge		-	0.3	-	
Q_{gd}	Gate-Drain Charge		-	0.1	-	
Source-Drain Characteristics						
$V_{SD}^{\text{(4)}}$	Diode Forward Voltage	$I_{SD}=0.3\text{A}, V_{GS}=0\text{V}$	-	0.75	1.1	V
t_{rr}	Reverse Recovery Time	$I_F=1\text{A}, V_R=10\text{V}$	-	9.2	-	nS
Q_{rr}	Reverse Recovery Charge		$dI_F/dt=100\text{A}/\mu\text{s}$	-	0.82	-

Note ⁽⁴⁾ : Pulse test (pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$).

Note ⁽⁵⁾ : Guaranteed by design, not subject to production testing.

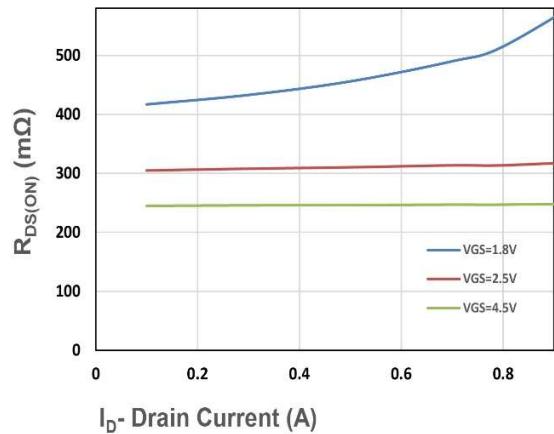
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N-Channel Typical Characteristics



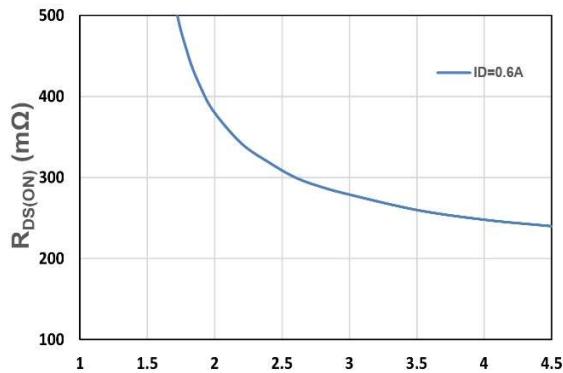
V_{DS} - Drain - Source Voltage (V)

Figure 1. Output Characteristics



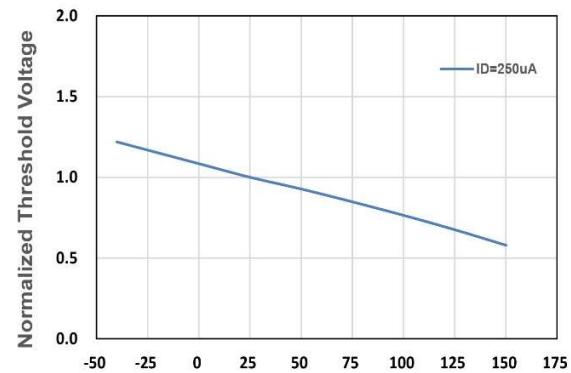
I_D - Drain Current (A)

Figure 2. On-Resistance vs. ID



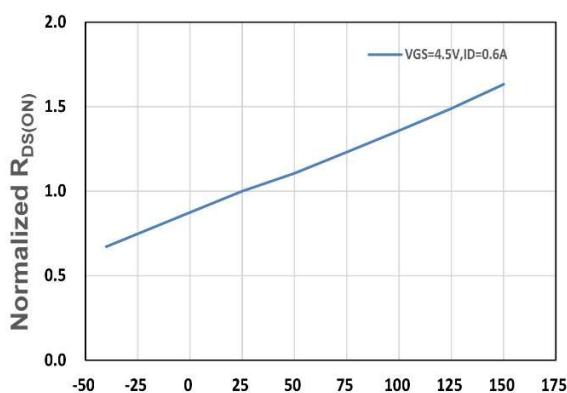
V_{GS} - Gate - Source Voltage (V)

Figure 3. On-Resistance vs. VGS



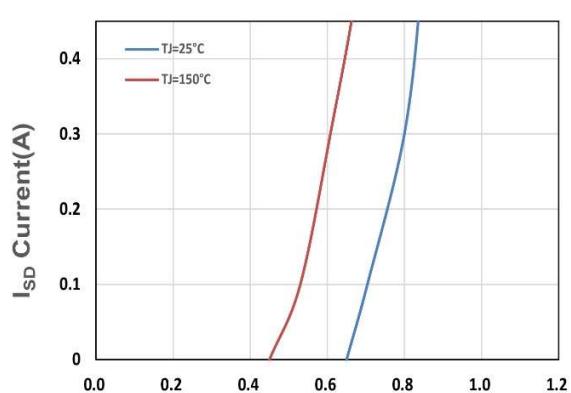
T_j , Junction Temperature(°C)

Figure 4. Gate Threshold Voltage



T_j , Junction Temperature(°C)

Figure 5. Drain-Source On Resistance

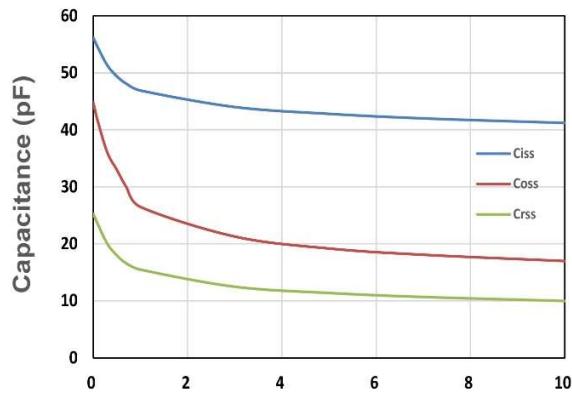


V_{SD} , Source-Drain Voltage(V)

Figure 6. Source-Drain Diode Forward

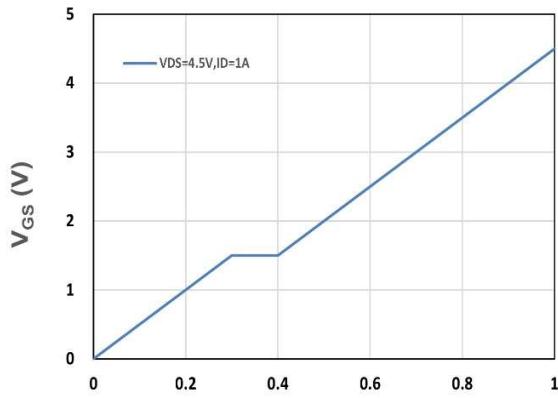
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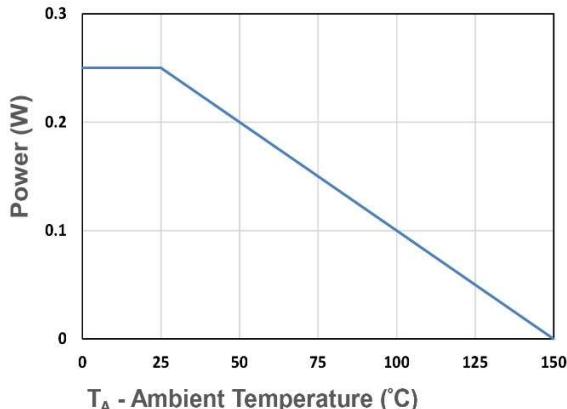
V_{DS} - Drain - Source Voltage (V)

Figure 7. Capacitance



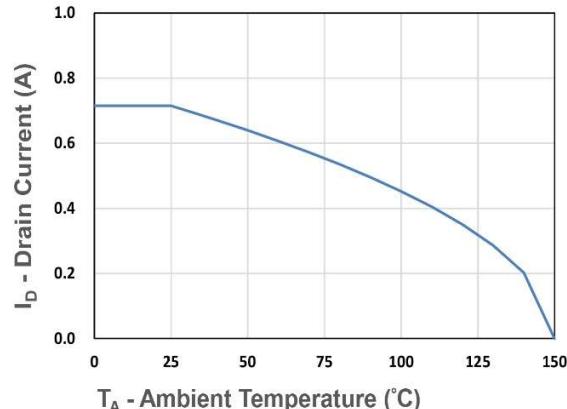
V_{GS} (V)

Figure 8. Gate Charge Characteristics



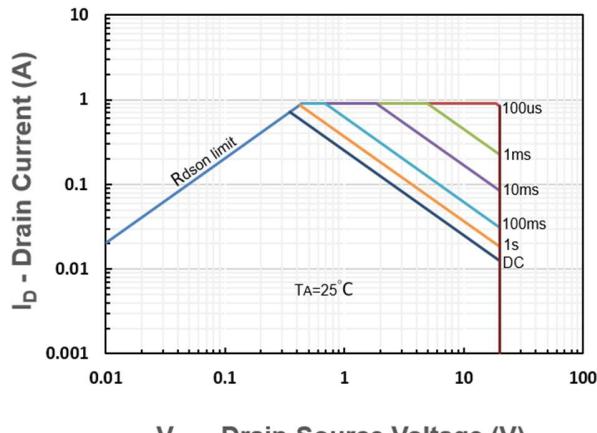
T_A - Ambient Temperature (°C)

Figure 9. Power Dissipation



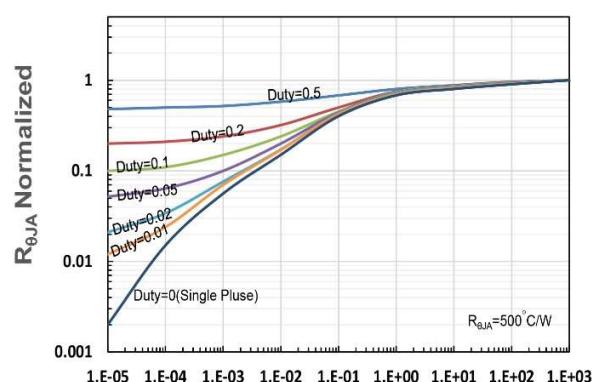
T_A - Ambient Temperature (°C)

Figure 10. Drain Current



V_{DS} - Drain-Source Voltage (V)

Figure 11. Safe Operating Area



t_1 , Square Wave Pulse Duration(s)

Figure 12. $R_{θJA}$ Transient Thermal Impedance

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P-Channel Electrical Characteristics ($T_J=25^\circ\text{C}$ Unless Otherwise Noted)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
Static Electrical Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}, I_{\text{DS}}=-250\mu\text{A}$	-20	-	-	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{\text{DS}}=-16 \text{ V}$, $V_{\text{GS}}=0\text{V}$	-	-	-1	μA
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{DS}}=-250\mu\text{A}$	-0.5	-0.75	-1	V
I_{GSS}	Gate Leakage Current	$V_{\text{GS}}=\pm 12 \text{ V}$, $V_{\text{DS}}=0\text{V}$	-	-	± 10	μA
$R_{\text{DS(ON)}}^{\text{(1)}}$	Drain-Source On-state Resistance	$V_{\text{GS}}=-4.5\text{V}, I_{\text{DS}}=-0.43\text{A}$	-	500	600	$\text{m}\Omega$
		$V_{\text{GS}}=-2.5\text{V}, I_{\text{DS}}=-0.3\text{A}$	-	680	900	
		$V_{\text{GS}}=-1.8\text{V}, I_{\text{DS}}=-0.01\text{A}$	-	800	1200	
g_{fs}	Forward Transconductance	$V_{\text{DS}}=-3\text{V}, I_{\text{DS}}=-0.22\text{A}$	-	0.85	-	S
Dynamic Characteristics ⁽²⁾						
C_{iss}	Input Capacitance	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=-10\text{V}, \text{Freq.}=1\text{MHz}$	-	57.8	-	pF
C_{oss}	Output Capacitance		-	5.6	-	
C_{rss}	Reverse Transfer Capacitance		-	4.3	-	
$t_{\text{d(ON)}}$	Turn-on Delay Time	$V_{\text{GS}}=-4.5\text{V}, V_{\text{DS}}=-10\text{V}, I_{\text{D}}=-1\text{A}, R_{\text{GEN}}=6\Omega$	-	0.4	-	nS
t_r	Turn-on Rise Time		-	0.03	-	
$t_{\text{d(OFF)}}$	Turn-off Delay Time		-	0.04	-	
t_f	Turn-off Fall Time		-	1.1	-	
Q_g	Total Gate Charge	$V_{\text{GS}}=-2.5\text{V}, V_{\text{DS}}=-10\text{V}, I_{\text{D}}=-0.43\text{A}$	-	0.6	-	nC
Q_g	Total Gate Charge	$V_{\text{GS}}=-4.5\text{V}, V_{\text{DS}}=-10\text{V}, I_{\text{D}}=-0.43\text{A}$	-	1	-	
Q_{gs}	Gate-Source Charge		-	0.17	-	
Q_{gd}	Gate-Drain Charge		-	0.18	-	
Source-Drain Characteristics						
$V_{\text{SD}}^{\text{(2)}}$	Diode Forward Voltage	$I_{\text{SD}}=-0.22\text{A}, V_{\text{GS}}=0\text{V}$	-	-0.8	-1.1	V
t_{rr}	Reverse Recovery Time	$I_F=-0.22\text{A}, V_R=-10\text{V}$	-	60	-	nS
Q_{rr}	Reverse Recovery Charge	$dI_F/dt=100\text{A}/\mu\text{s}$	-	50	-	nC

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P-Channel Typical Characteristics

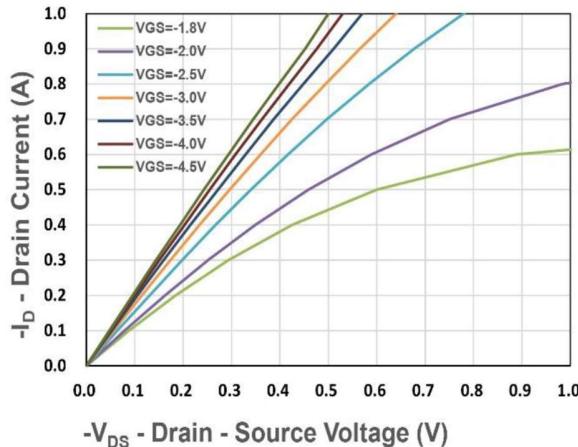


Figure 1. Output Characteristics

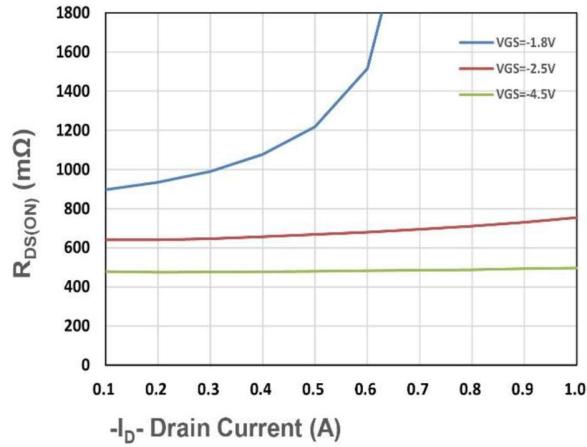


Figure 2. On-Resistance vs. ID

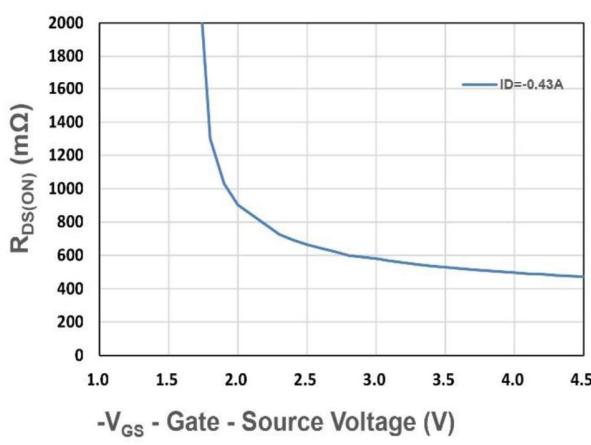


Figure 3. On-Resistance vs. VGS

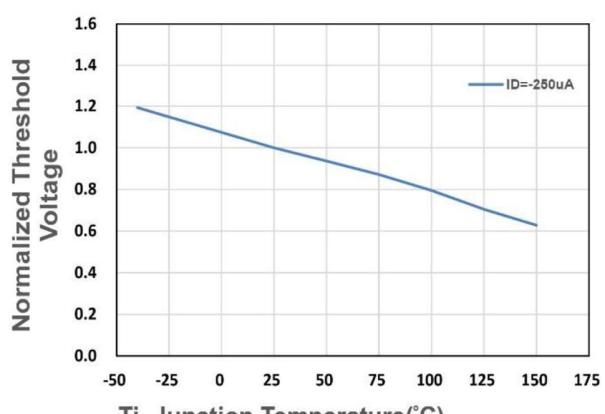


Figure 4. Gate Threshold Voltage

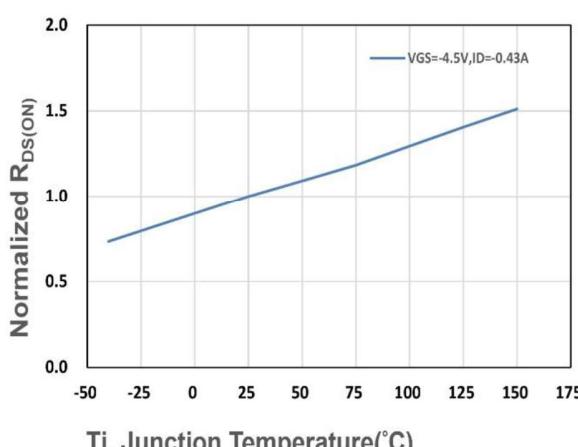


Figure 5. Drain-Source On Resistance

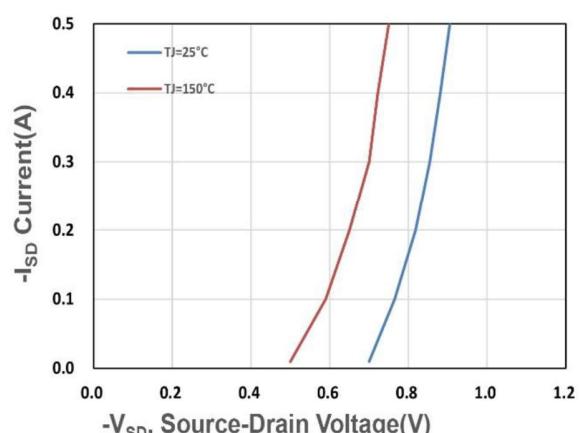
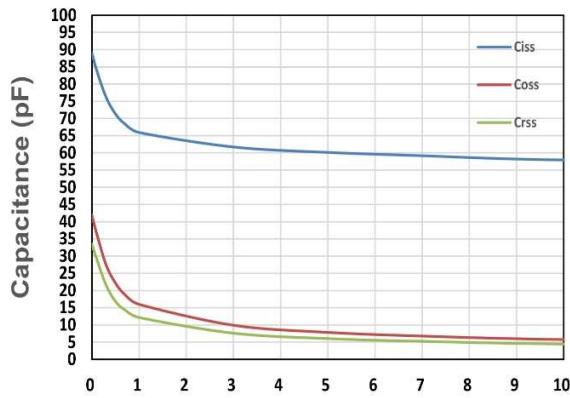


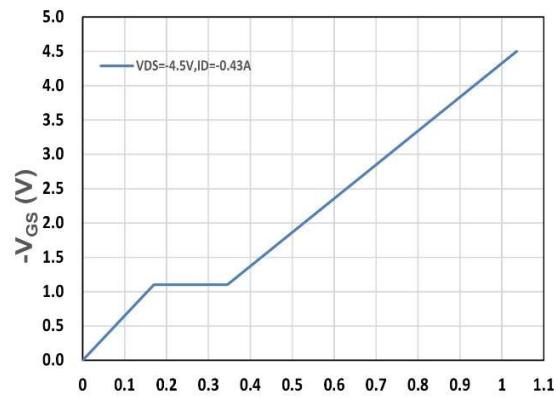
Figure 6. Source-Drain Diode Forward

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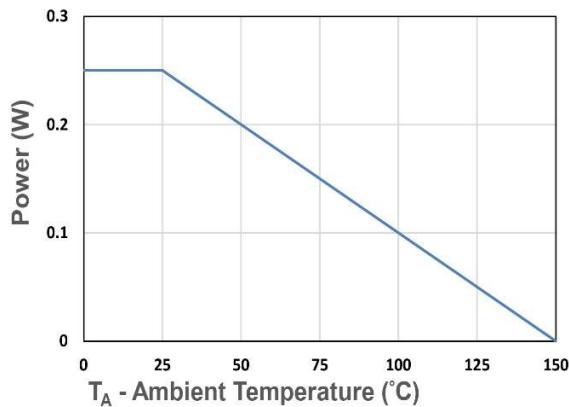
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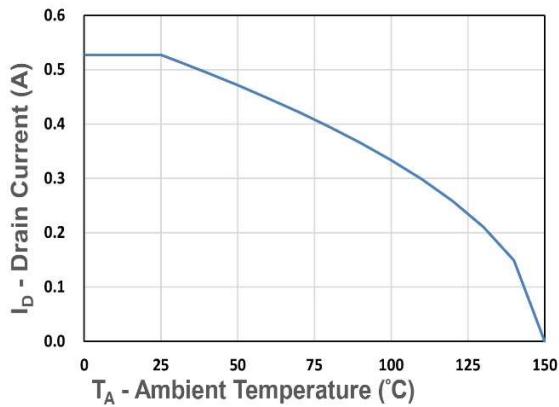
-V_{DS} - Drain - Source Voltage (V)
Figure 7. Capacitance



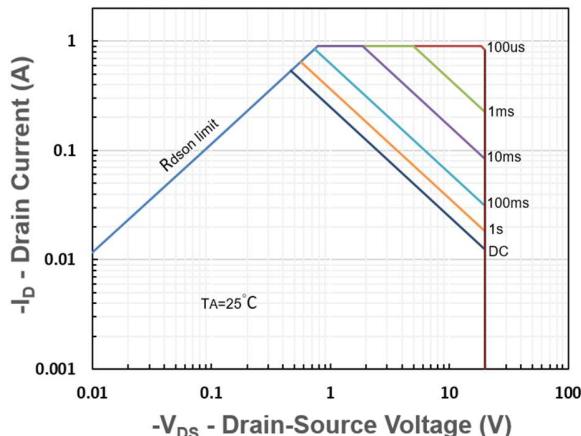
-V_{GS} (V)
Q_g, Total Gate Charge (nC)
Figure 8. Gate Charge Characteristics



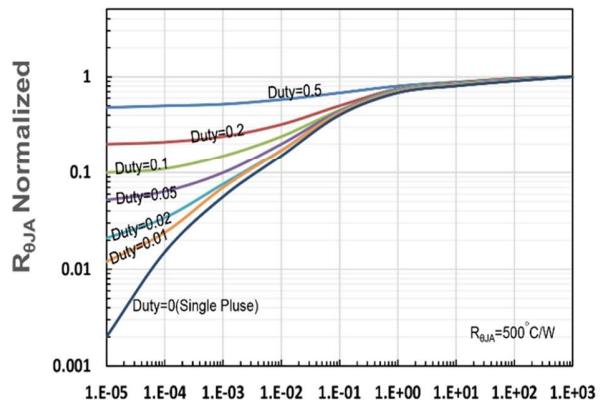
Power (W)
T_A - Ambient Temperature (°C)
Figure 9. Power Dissipation



I_D - Drain Current (A)
T_A - Ambient Temperature (°C)
Figure 10. Drain Current



-I_D - Drain Current (A)
-V_{DS} - Drain-Source Voltage (V)
Figure 11. Safe Operating Area



R_{θJA} Normalized
t₁, Square Wave Pulse Duration(s)
Figure 12. R_{θJA} Transient Thermal Impedance